

### FEATURES

#### Ultracompact solution

- Small, 2 mm × 1.5 mm, 12-ball WLCSP package
- Smallest footprint, 1 mm height, 1  $\mu$ H power inductor
- LED current source for local LED grounding
- Simplified routing to/from LED
- Improved LED thermals

#### Synchronous 3 MHz PWM boost converter, no external diode

#### High efficiency: 90% peak

- Reduces high levels of input battery current during flash
- Limits battery current drain in torch mode

#### I<sup>2</sup>C programmable

- Currents up to 1500 mA in flash mode for one LED with 7% accuracy over all conditions
- Currents up to 200 mA in torch mode
- Programmable dc battery current limit (4 settings)
- Programmable flash timer up to 1600 ms
- Low VBAT mode to reduce LED current automatically
- 4-bit ADC for LED  $V_F$ , die/LED temperature readback

#### Control

- I<sup>2</sup>C-compatible control registers
- External STROBE and torch input pins
- 2 transmitter mask (TxMASK) inputs

#### Safety

- Thermal overload protection
- Inductor fault detection
- LED short-/open-circuit protection

### APPLICATIONS

- Camera-enabled cellular phones and smart phones
- Digital still cameras, camcorders, and PDAs

### GENERAL DESCRIPTION

The ADP1650 is a very compact, highly efficient, single white LED flash driver for high resolution camera phones that improves picture and video quality in low light environments. The device integrates a programmable 1.5 MHz or 3.0 MHz synchronous inductive boost converter, an I<sup>2</sup>C-compatible interface, and a 1500 mA current source. The high switching frequency enables the use of a tiny, 1 mm high, low cost, 1  $\mu$ H power inductor, and the current source permits LED cathode grounding for thermally enhanced, low EMI, and compact layouts.

The LED driver maximizes efficiency over the entire battery voltage range to maximize the input-power-to-LED-power

### FUNCTIONAL BLOCK DIAGRAM

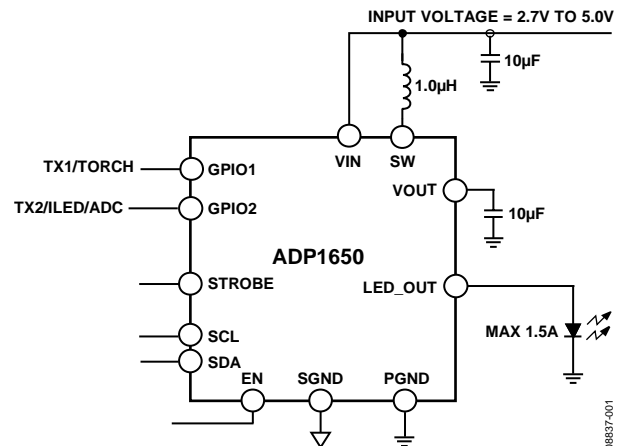


Figure 1.

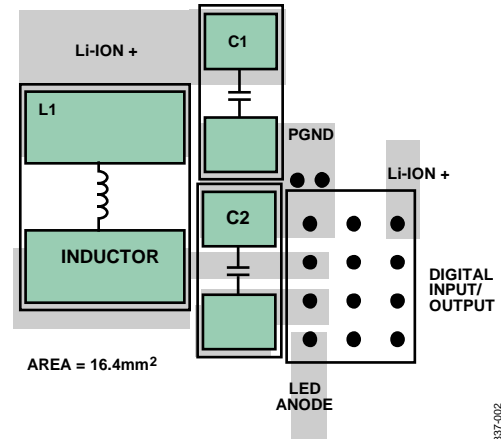


Figure 2. PCB Layout

conversion and minimize battery current draw during flash events. A programmable dc battery current limit safely maximizes LED current for all LED  $V_F$  and battery voltage conditions.

Two independent TxMASK inputs permit the flash LED current and battery current to reduce quickly during a power amplifier current burst. The I<sup>2</sup>C-compatible interface enables the programmability of timers, currents, and status bit readback for operation monitoring and safety control.

The ADP1650 comes in a compact 12-ball, 0.5 mm pitch package and operates within specification over the full  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  junction temperature range.

#### Rev. 0

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## REVISION HISTORY

4/10—Revision 0: Initial Version

## SPECIFICATIONS

$V_{IN}^1 = 3.6\text{ V}$ ,  $T_J = -40^\circ\text{C}$  to  $+125^\circ\text{C}$  for minimum/maximum specifications, and  $T_A = 25^\circ\text{C}$  for typical specifications, unless otherwise noted.

Table 1.

Parameter <sup>2</sup>	Conditions	Min	Typ	Max	Unit
SUPPLY					
Input Voltage Range	V <sub>IN</sub> falling	2.7		5.0	V
Undervoltage Lockout Threshold		2.3	2.4	2.5	V
Undervoltage Lockout Hysteresis		50	100	150	mV
Shutdown Current, EN = 0 V	T <sub>J</sub> = −40°C to +85°C, current into VIN pin, V <sub>IN</sub> = 2.7 V to 4.5 V		0.2	1	μA
Standby Current, EN = 1.8 V	T <sub>J</sub> = −40°C to +85°C, current into VIN pin, V <sub>IN</sub> = 2.7 V to 4.5 V		3	10	μA
Operating Quiescent Current	Torch mode, LED current = 100 mA		5.3		mA
SW Switch Leakage	T <sub>J</sub> = −40°C to +85°C, V <sub>SW</sub> <sup>3</sup> = 4.5 V			2	μA
	T <sub>J</sub> = 25°C, V <sub>SW</sub> <sup>3</sup> = 4.5 V			0.5	μA
LED DRIVER					
LED Current	Assist light value setting = 0 (000 binary) Assist light value setting = 7 (111 binary) Flash value setting = 0 (00000 binary) Flash value setting = 24 (11000 binary)		25		mA
Assist Light, Torch			200		mA
Flash			300		mA
			1500		mA
LED Current Error	I <sub>LED</sub> = 700 mA to 1100 mA	−6		+6	%
	I <sub>LED</sub> = 300 mA to 650 mA, 1150 mA to 1500mA	−7		+7	%
	I <sub>LED</sub> = 75 mA to 200 mA	−10		+10	%
	I <sub>LED</sub> = 25 mA to 50mA	−15		+15	%
LED Current Source Headroom	Flash, 1200 mA LED current		290		mV
	Torch, 200 mA LED current		190		mV
LED_OUT Ramp-Up Time				0.6	ms
LED_OUT Ramp-Down Time				0.1	ms
SWITCHING REGULATOR					
Switching Frequency	Switching frequency = 3 MHz	2.8	3	3.2	MHz
	Switching frequency = 1.5 MHz	1.4	1.5	1.6	MHz
Minimum Duty Cycle	Switching frequency = 3 MHz		14		%
	Switching frequency = 1.5 MHz		7		%
N-FET Resistance			60		mΩ
P-FET Resistance			50		mΩ
Voltage Output Mode					
VOUT Voltage	ILOAD at VOUT = 300 mA	4.575	5	5.425	V
Output Current				500	mA
Line Regulation			0.3		%/V
Load Regulation			−0.7		%/A
Pass-Through Mode Transition, Flash					
VIN to LED_OUT, Entry	1200 mA LED current		580		mV
VIN to LED_OUT Exit	1200 mA LED current		435		mV
Pass-Through Mode Transition, Torch					
VIN to LED_OUT, Entry	200 mA LED current		380		mV
VIN to LED_OUT, Exit	200 mA LED current		285		mV
DIGITAL INPUTS/GPIO					
Input Logic Low Voltage				0.54	V
Input Logic High Voltage		1.26			V

# ADP1650

Parameter <sup>2</sup>	Conditions	Min	Typ	Max	Unit
GPIO1, GPIO2, STROBE Pull-Down Torch Glitch Filtering Delay	From torch rising edge to device start	7.4	390 8	8.6	kΩ ms
INDICATOR LED					
LED Current Accuracy		–22		+22	%
Short-Circuit Detection Threshold				1.2	V
Open-Circuit Detection Threshold		2.45			V
ADC					
Resolution		4			bits
Error	External voltage mode V <sub>F</sub> mode, T <sub>J</sub> = 25°C		0	±1	LSB
	V <sub>F</sub> Mode, T <sub>J</sub> = –40°C to +125°C			±1	LSB
				±1.5	LSB
Input Voltage Range, GPIO2	External voltage mode	0		0.5	V
SAFETY FEATURES					
Maximum Timeout For Flash			1600		ms
Timer Accuracy		–7.0		+7.0	%
DC Current Limit	DC current value setting = 0 (00 binary)	1.35	1.5	1.65	A
	DC current value setting = 1 (01 binary)	1.55	1.75	1.95	A
	DC current value setting = 2 (10 binary)	1.8	2.0	2.2	A
	DC current value setting = 3 (11 binary)	2.02	2.25	2.5	A
Low VBAT Mode Transition Voltage					
Error				3.2	%
Hysteresis			50		mV
Coil Peak Current Limit	Peak current value setting = 0 (00 binary)	1.55	1.75	1.95	A
	Peak current value setting = 1 (01 binary)	2.02	2.25	2.5	A
	Peak current value setting = 2 (10 binary)	2.47	2.75	3.0	A
	Peak current value setting = 3 (11 binary)	2.7	3.0	3.3	A
Overvoltage Detection Threshold		5.15	5.5	5.9	V
LED_OUT Short-Circuit Detection			1.2	1.3	V
Comparator Reference Voltage					
Thermal Shutdown Threshold					
T <sub>J</sub> Rising			150		°C
T <sub>J</sub> Falling			140		°C

<sup>1</sup> V<sub>IN</sub> is the input voltage to the circuit.

<sup>2</sup> All limits at temperature extremes are guaranteed via correlation using standard statistical quality control (SQC).

<sup>3</sup> V<sub>SW</sub> is the voltage on the SW switch pin.

## RECOMMENDED SPECIFICATIONS: INPUT AND OUTPUT CAPACITANCE AND INDUCTANCE

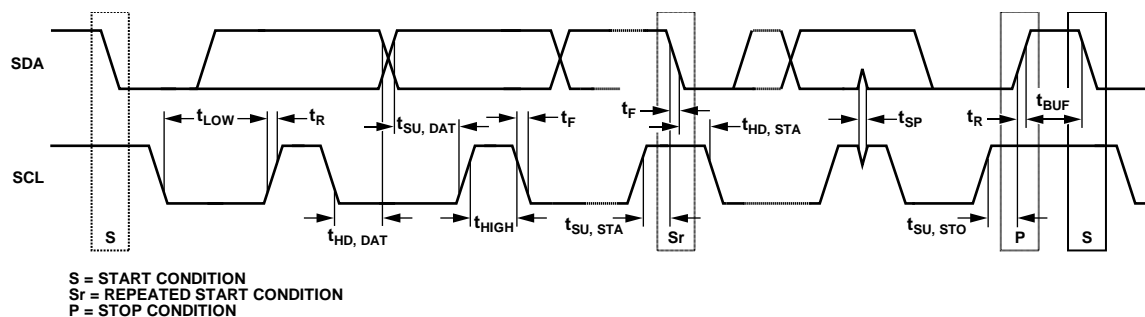
Table 2.

Parameter	Symbol	Conditions	Min	Typ	Max	Unit
CAPACITANCE	C <sub>MIN</sub>					
Input		T <sub>A</sub> = –40°C to +125°C	4.0	10		μF
Output		T <sub>A</sub> = –40°C to +125°C	3.0	10	20	μF
MINIMUM AND MAXIMUM INDUCTANCE	L	T <sub>A</sub> = –40°C to +125°C	0.6	1.0	1.5	μH

I<sup>2</sup>C-COMPATIBLE INTERFACE TIMING SPECIFICATIONS

Table 3.

Parameter <sup>1</sup>	Min	Max	Unit	Description
f <sub>SCL</sub>		400	kHz	SCL clock frequency
t <sub>HIGH</sub>	0.6		μs	SCL high time
t <sub>LOW</sub>	1.3		μs	SCL low time
t <sub>SU, DAT</sub>	100		ns	Data setup time
t <sub>HD, DAT</sub>	0	0.9	μs	Data hold time
t <sub>SU, STA</sub>	0.6		μs	Setup time for repeated start
t <sub>HD, STA</sub>	0.6		μs	Hold time for start/repeated start
t <sub>BUF</sub>	1.3		μs	Bus free time between a stop and a start condition
t <sub>SU, STO</sub>	0.6		μs	Setup time for stop condition
t <sub>R</sub>	20 + 0.1 C <sub>B</sub> <sup>2</sup>	300	ns	Rise time of SCL and SDA
t <sub>F</sub>	20 + 0.1 C <sub>B</sub> <sup>2</sup>	300	ns	Fall time of SCL and SDA
t <sub>SP</sub>	0	50	ns	Pulse width of suppressed spike
C <sub>B</sub> <sup>2</sup>		400	pF	Capacitive load for each bus line

<sup>1</sup> Guaranteed by design.<sup>2</sup> C<sub>B</sub> is the total capacitance of one bus line in picofarads.Figure 3. I<sup>2</sup>C-Compatible Interface Timing Diagram

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## ABSOLUTE MAXIMUM RATINGS

Table 4.

Parameter	Rating
VIN, SDA, SCL, EN, GPIO1, GPIO2, STROBE, LED_OUT, SW, VOUT to GND	−0.3 V to +6 V
PGND to SGND	−0.3 V to +0.3 V
Ambient Temperature Range (T <sub>A</sub> )	−40°C to +85°C
Junction Temperature Range (T <sub>J</sub> )	−40°C to +125°C
Storage Temperature	JEDEC J-STD-020
ESD Human Body Model	±2000 V
ESD Charged Device Model	±500 V
ESD Machine Model	±150 V

Stresses above those listed under Absolute Maximum Ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational section of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

### THERMAL DATA

The ADP1650 may be damaged if the junction temperature limits are exceeded. Monitoring T<sub>A</sub> does not guarantee that T<sub>J</sub> is within the specified temperature limits. In applications with high power dissipation and poor thermal resistance, the maximum T<sub>A</sub> may have to be derated. In applications with moderate power dissipation and low PCB thermal resistance, the maximum T<sub>A</sub> can exceed the maximum limit as long as the T<sub>J</sub> is within specification limits. T<sub>J</sub> of the device is dependent on the T<sub>A</sub>, the power dissipation (PD) of the device, and the junction-to-ambient thermal resistance (θ<sub>JA</sub>) of the package. Maximum T<sub>J</sub> is calculated from the T<sub>A</sub> and PD using the following formula:

$$T_J = T_A + (PD \times \theta_{JA})$$

### THERMAL RESISTANCE

θ<sub>JA</sub> of the package is based on modeling and calculation using a 4-layer board. θ<sub>JA</sub> is highly dependent on the application and board layout. In applications where high maximum power dissipation exists, attention to thermal board design is required. The value of θ<sub>JA</sub> may vary, depending on PCB material, layout, and environmental conditions. The specified value of θ<sub>JA</sub> is based on a 4-layer, 4 in × 3 in, 2 1/2 oz copper board, per JEDEC standards. For more information, see the AN-617 Application Note, *MicroCSP™ Wafer Level Chip Scale Package*.

θ<sub>JA</sub> is specified for a device mounted on a JEDEC 2S2P PCB.

Table 5. Thermal Resistance

Package Type	θ <sub>JA</sub>	Unit
12-Ball WLCSP	75	°C/W

### ESD CAUTION



**ESD (electrostatic discharge) sensitive device.** Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

## PIN CONFIGURATIONS AND FUNCTION DESCRIPTIONS

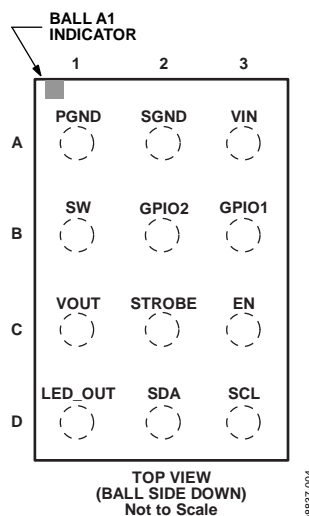


Figure 4. Pin Configuration

Table 6. Pin Function Descriptions

Pin No.	Mnemonic	Description
A1	PGND	Power Ground.
A2	SGND	Signal Ground.
A3	VIN	Input Voltage for the Device. Connect an input bypass capacitor close to this pin.
B1	SW	Boost Switch. Connect the power inductor between SW and the input capacitor.
B2	GPIO2	ILED/TX2/ADC. Mode is register selectable. Red indicator LED current source or TxMASK2 or ADC input. ILED Mode. Connect to red LED anode. Connect the LED cathode to GND. TxMASK2 Mode. Reduces the current to the programmable TxMASK2 current. ADC Mode. This pin is used as the input pin for the ADC.
B3	GPIO1	Torch/TX1. Mode is register selectable. External torch mode or TxMASK1 input. Torch Mode. Enables the integrated circuit (IC) in direct torch mode. TxMASK1 Mode. Reduces the flash current to the programmable TxMASK1 current.
C1	VOUT	Boost Output. Connect an output bypass capacitor very close to this pin. This is the output for the 5 V external voltage mode.
C2	STROBE	Strobe Signal Input. This pin synchronizes the flash pulse to the image capture. In most cases, this signal comes directly from the image sensor.
C3	EN	Enable. Set EN low to bring the quiescent current ( $I_q$ ) to $<1 \mu A$ . Registers are set to their defaults when EN is brought from low to high.
D1	LED_OUT	LED Current Source. Connect this pin to the anode of the flash LED.
D2	SDA	I <sup>2</sup> C Data Signal in I <sup>2</sup> C Mode.
D3	SCL	I <sup>2</sup> C Clock Signal in I <sup>2</sup> C Mode.

## TYPICAL PERFORMANCE CHARACTERISTICS

IL = inductor current, ILED = LED current, LED OUT = LED output, IBAT = battery current.

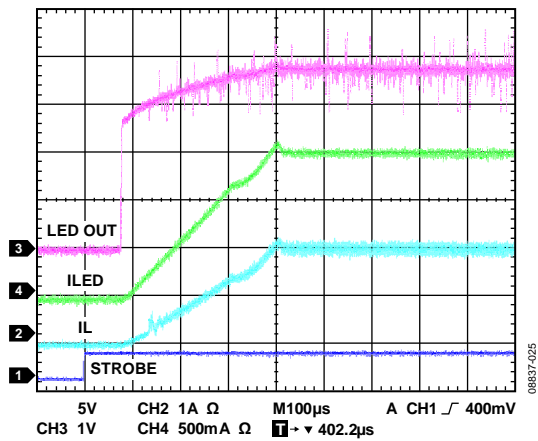


Figure 4. Startup Flash Mode,  $V_{IN} = 3.6\text{ V}$ ,  $I_{LED} = 1500\text{ mA}$

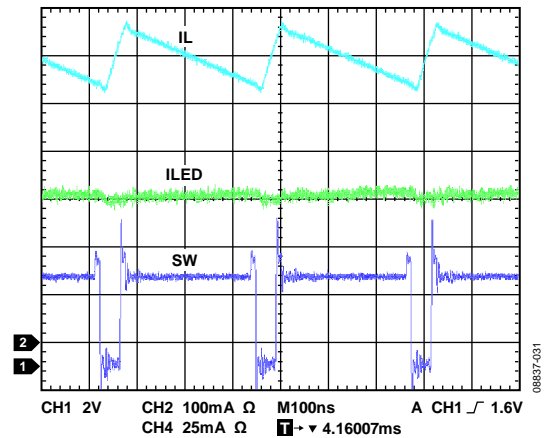


Figure 7. Switching Waveforms, Flash Mode,  $I_{LED} = 1500\text{ mA}$

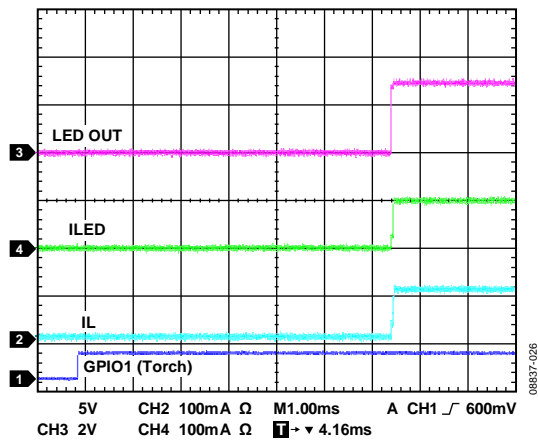


Figure 5. Startup Torch Mode,  $V_{IN} = 3.6\text{ V}$ ,  $I_{LED} = 100\text{ mA}$

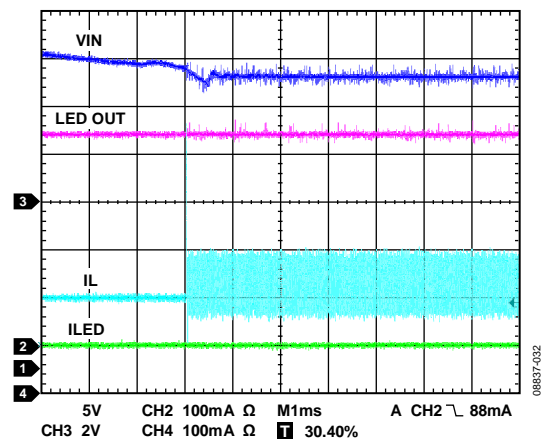


Figure 8. Pass Through to Boost Mode Transition,  $I_{LED} = 100\text{ mA}$

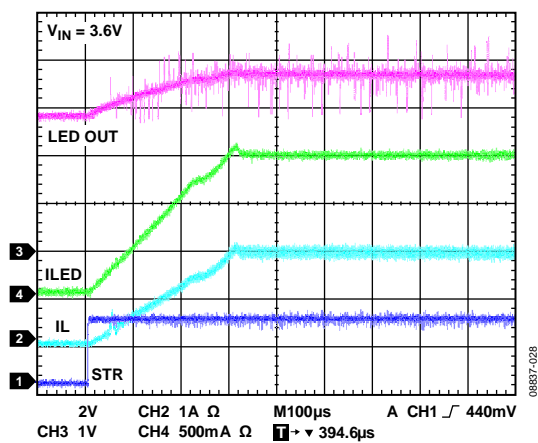


Figure 6. 100 mA Torch to 1500 mA Flash Transition

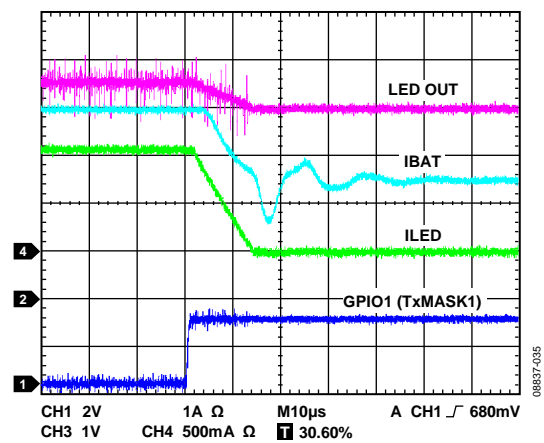


Figure 9. Entry into TxMASK Mode



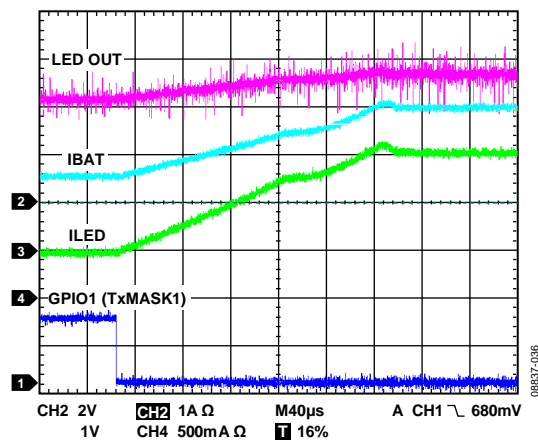


Figure 10. Exit from TxMASK Mode

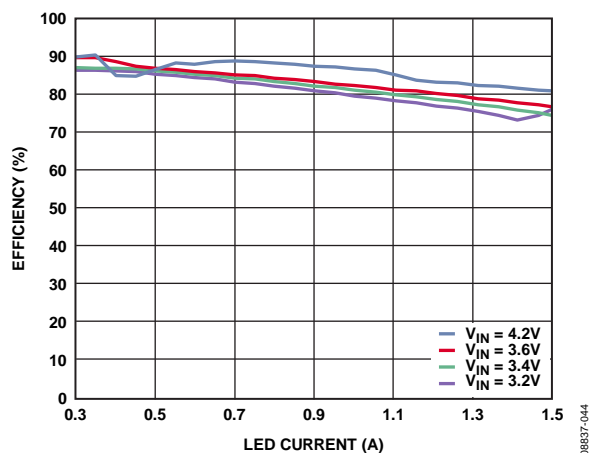


Figure 13. Flash Mode Efficiency vs. LED Current

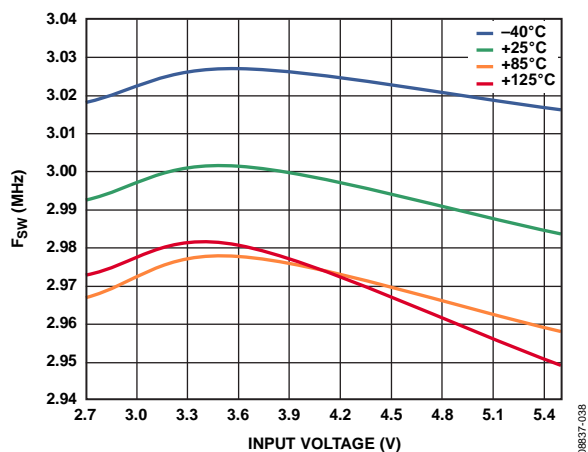


Figure 11. Switching Frequency vs. Supply Voltage (3 MHz Mode)

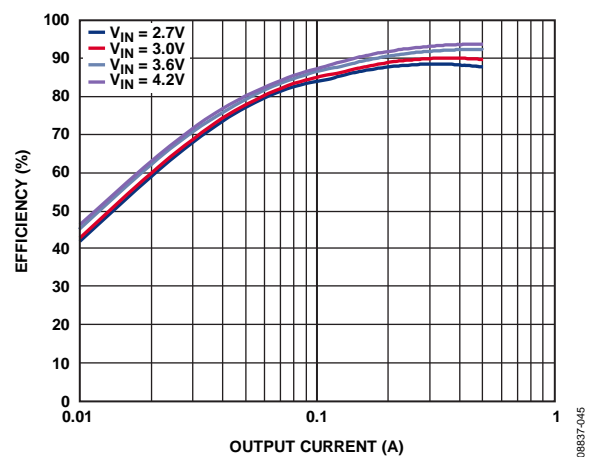


Figure 14. Voltage Regulation Mode Efficiency vs. Load Current

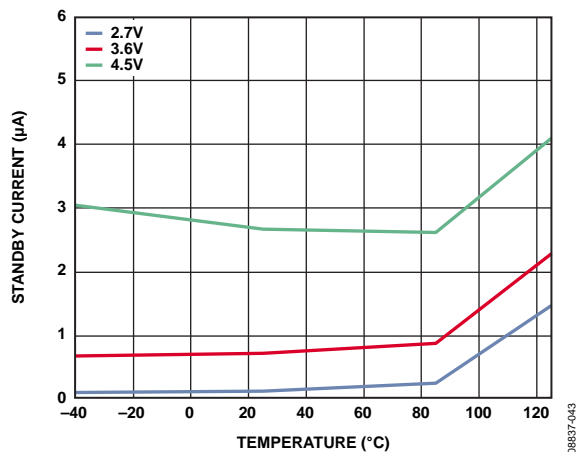


Figure 12. Standby Current vs. Temperature

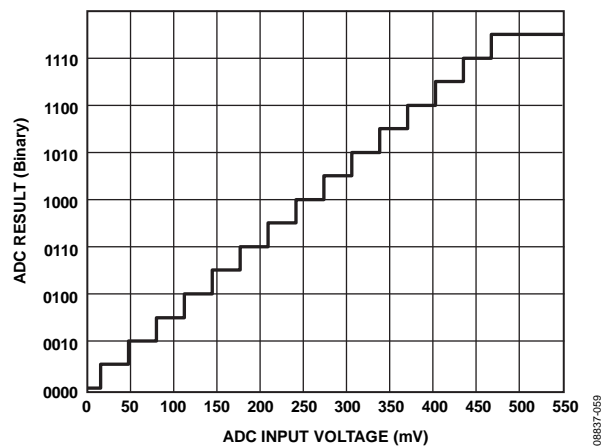


Figure 15. ADC External Voltage Mode Transfer Characteristic

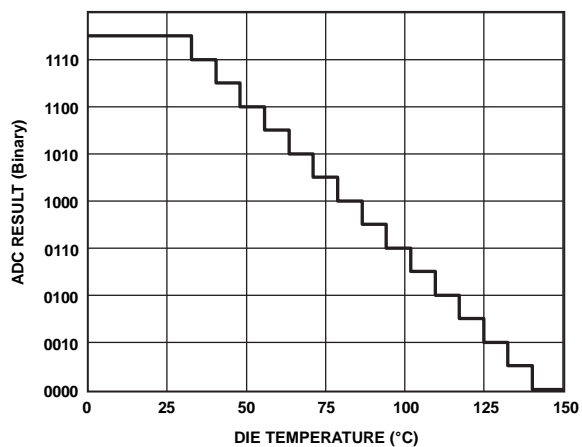


Figure 16. ADC Die Temperature Mode Transfer Characteristic

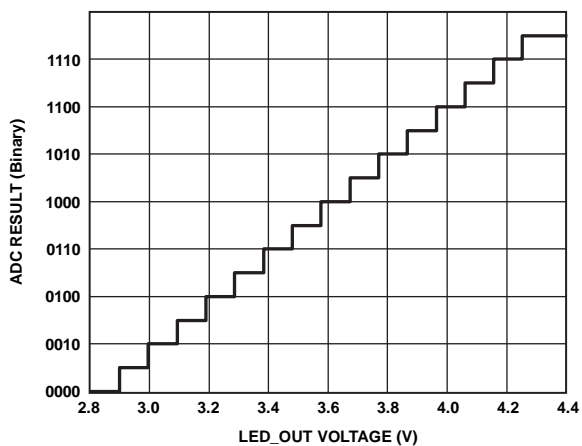


Figure 17. ADC LED  $V_F$  Mode Transfer Characteristic

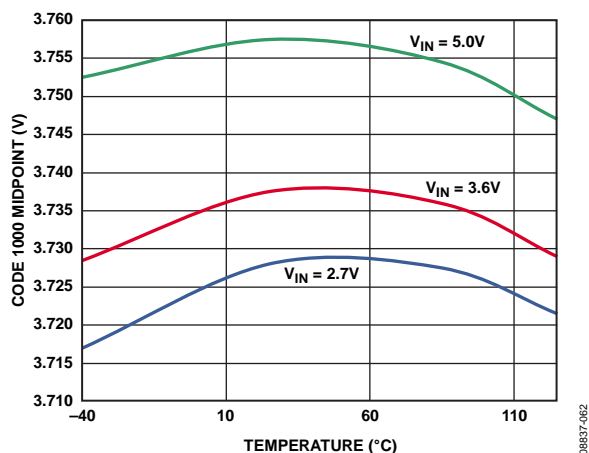


Figure 18. ADC LED  $V_F$  Mode, Code 1000, Midpoint vs. Temperature

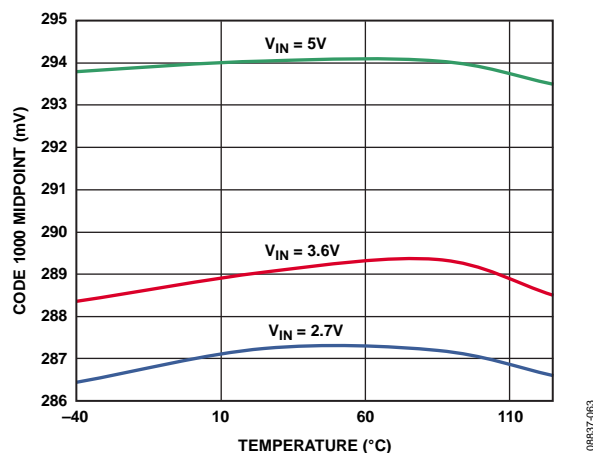


Figure 19. ADC External Voltage Mode, Code 1000 Midpoint vs. Temperature

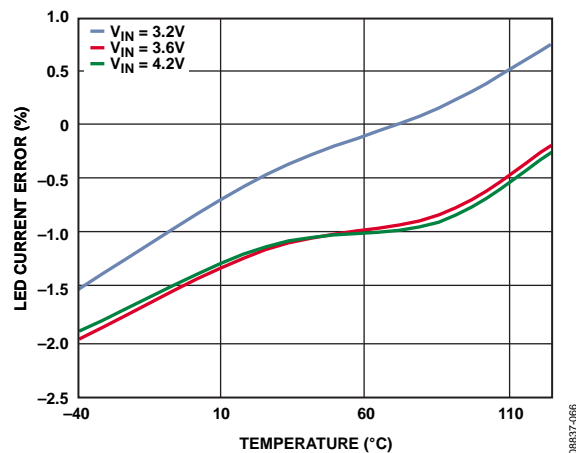


Figure 20. LED Current Accuracy vs. Temperature,  $I_{LED} = 1200\text{ mA}$

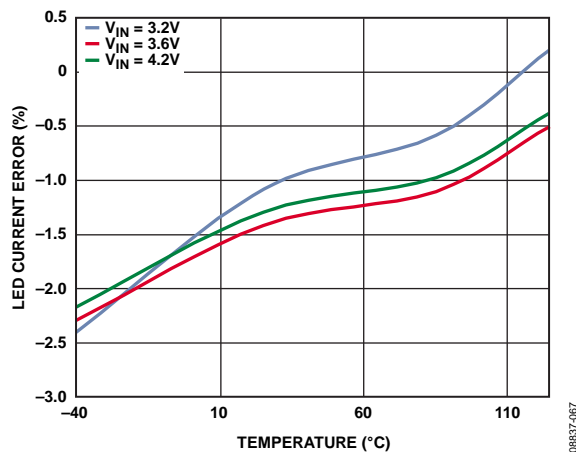


Figure 21. LED Current Accuracy vs. Temperature,  $I_{LED} = 800\text{ mA}$

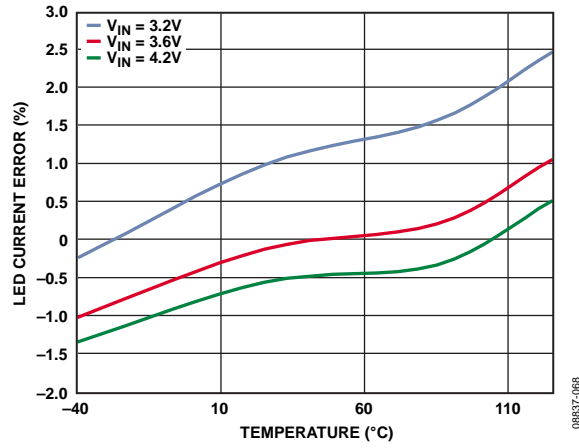


Figure 22. LED Current Accuracy vs. Temperature,  $I_{LED} = 1500 \text{ mA}$

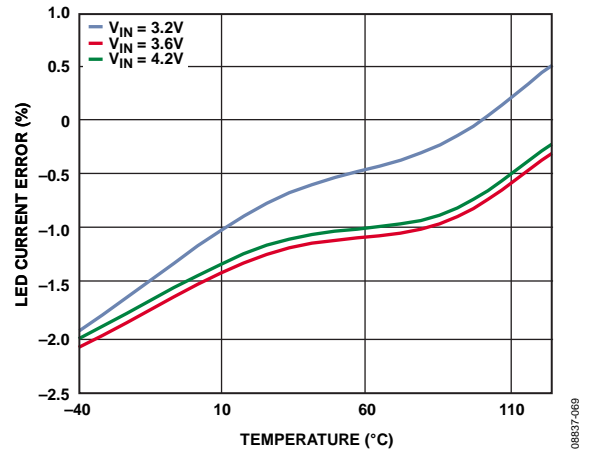


Figure 23. LED Current Accuracy vs. Temperature,  $I_{LED} = 1000 \text{ mA}$



## ASSIST LIGHT

The assist light provides continuous current programmable from 25 mA to 200 mA. Set the assist light current using the  $I\_TOR$  bits (in Register 0x03). To enable assist, set  $LED\_MOD$  to assist light mode and set  $OUTPUT\_EN = 1$  (in Register 0x04). Disable assist light mode by setting  $LED\_MOD$  to standby mode or setting  $OUTPUT\_EN = 0$ .

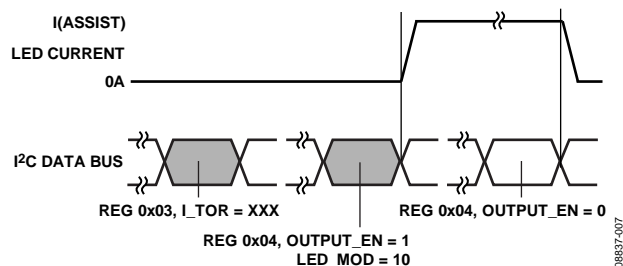


Figure 25. Enabling Assist Light Mode

## FLASH MODE

Flash mode provides 300 mA to 1.5 A for a programmable time of up to 1.6 seconds. Set the flash current using the  $I\_FL$  bits (in Register 0x03) and the maximum flash duration with the  $FL\_TIM$  bits (in Register 0x02). To enable flash mode, set  $LED\_MOD$  to flash mode and set  $OUTPUT\_EN = 1$ . Enable flash without  $STROBE$  by setting  $STR\_MODE$  (in Register 0x04) to 0 (software strobe). When  $STR\_MODE$  is in hardware strobe mode, setting the  $STROBE$  pin high enables flash and synchronizes it to the image sensor. Hardware strobe mode has two modes for timeout: level sensitive and edge sensitive.

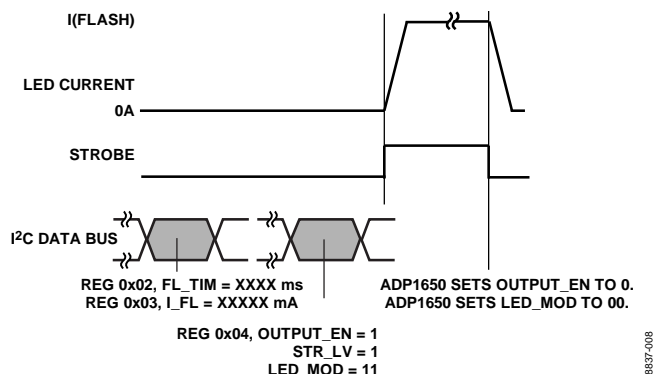


Figure 26. Flash Operation: Level-Sensitive Mode

In level-sensitive mode, the duration of  $STROBE$  high sets the duration of the flash up to the maximum time set by the  $FL\_TIM$  timeout. If  $STROBE$  is kept high longer than the duration set by  $FL\_TIM$ , a timeout fault disables the flash.

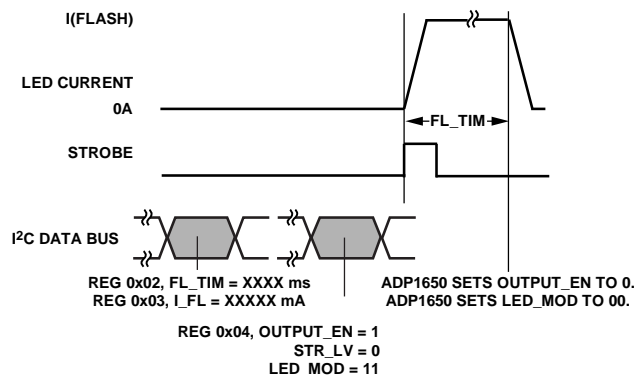


Figure 27. Flash Operation: Edge-Sensitive Mode

In edge-sensitive mode, a positive edge on the  $STROBE$  pin enables the flash, and the  $FL\_TIM$  bits set the flash duration.

## ASSIST TO FLASH OPERATION

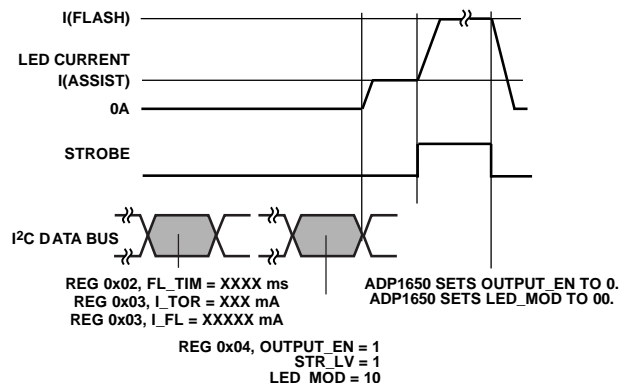


Figure 28. Enabling Assist to Flash (Level-Sensitive) Mode

The  $STR\_POL$  bit in Register 0x07 changes the default enable of  $STROBE$  from low to high to high to low. Additional image sensor-specific assist/flash enable modes are included in the device, and information on these is available on request from the Analog Devices, Inc., sales team.

## TORCH MODE

Set the assist/torch light current using the  $I\_TOR$  bits. To enable torch mode using a logic signal, set  $LED\_MOD$  to standby mode and  $OUTPUT\_EN = 1$ , and then bring  $GPIO1$  high. Disable external torch mode by setting  $GPIO1$  low or programming  $OUTPUT\_EN = 0$ . Bringing  $GPIO1$  low during torch mode automatically sets  $OUTPUT\_EN = 0$ . To enable torch mode again, program  $OUTPUT\_EN = 1$ , and bring  $GPIO$  high again.

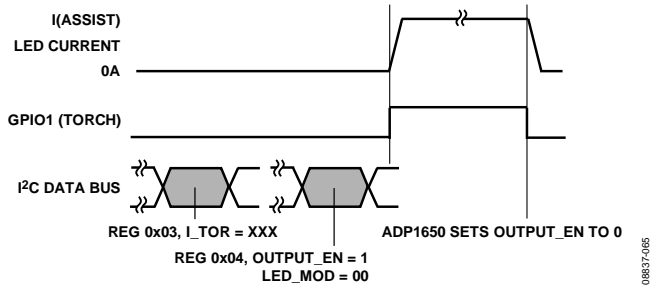


Figure 29. . Enabling External Torch Mode Using GPIO1

## TORCH-TO-FLASH MODE

The driver can move directly from external torch mode (using GPIO1) to flash mode by bringing STROBE high before GPIO1 = torch is brought low. Bringing torch low before STROBE goes high prevents the flash from firing when STROBE goes high.

The ADP1650 returns to standby mode after a successful flash and sets OUTPUT\_EN = 0.

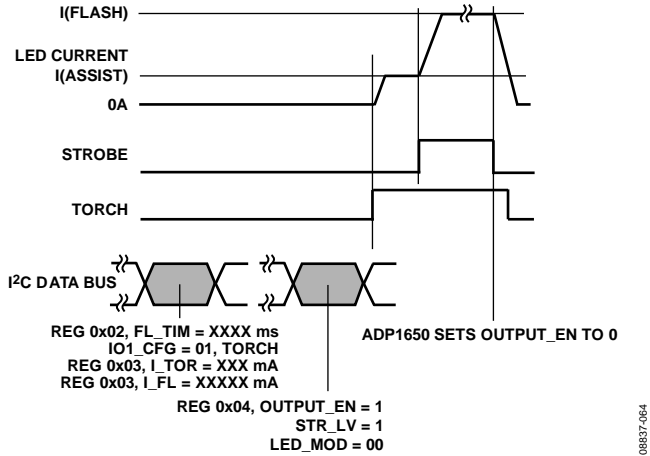


Figure 30. . Enabling Flash Mode from External Torch Mode

## TXMASK OPERATION

When the ADP1650 is in flash mode, the TxMASK1 and TxMASK2 functions reduce the battery load in response to the system enabling a power amplifier. The device remains in flash mode, but the LED driver output current reduces to the programmed TxMASK light level in less than 21  $\mu$ s.

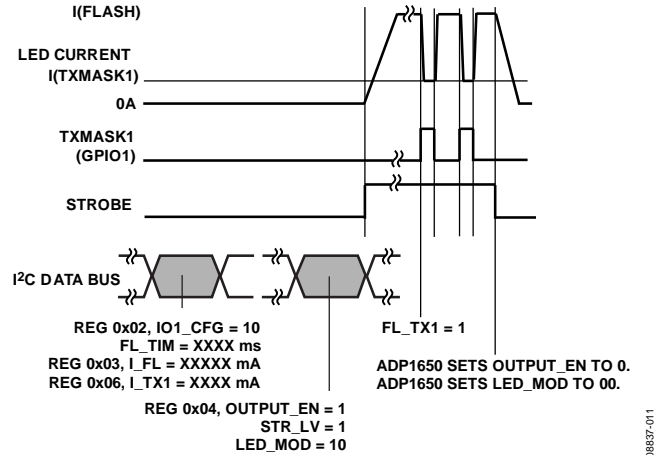


Figure 31. TxMASK Operation During Flash (Level-Sensitive) Mode

The device selects the TxMASK1 or TxMASK2 current level based on whether TxMASK1 or TxMASK2 input is used. After a TxMASK1 or TxMASK2 occurs, a flag is set in the fault information register. When the TxMASK signal goes low again, the LED current goes back to the full flash level in a controlled manner to avoid overshoots on the battery current. If both TxMASK inputs are set high simultaneously, the TXMASK1 current level is used.

## FREQUENCY FOLDBACK

Frequency foldback is an optional mode that optimizes efficiency by reducing the switching frequency to 1.5 MHz when VIN is slightly less than VOUT. Enable frequency foldback by setting FREQ\_FB = 1 in Register 0x04.

## INDICATOR LED DRIVER

The indicator LED driver on GPIO2 provides a programmable current source of between 2.75 mA and 11 mA for driving a red privacy LED. The current level is programmed by the I\_LED bits in Register 0x07. The circuit consists of a programmable current source and a monitoring circuit that uses comparators to determine whether the indicator LED is shorted or open. The threshold for detection of a short is 1.2 V(maximum) and an open circuit is 2.45 V(minimum). The indicator LED must not be used at the same time as a flash or assist/torch event.

## LOW BATTERY LED CURRENT FOLDBACK

As the battery discharges, the lower battery voltage results in higher peak currents through the battery ESR, which may cause early shutdown of the phone. The ADP1650 features an optional low battery detection option, which reduces the flash current (to a programmable level) when the battery voltage falls below a programmable level.

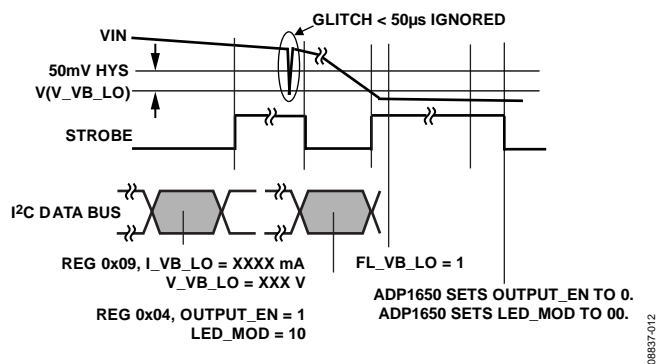


Figure 32. Register 0x09 Sets the Battery Voltage Threshold Level and the Reduced LED Current Level

Table 6. VDD Level at Which the VBAT Low Function Is Enabled

Bit Name	VDD Level
V_VB_LO	000 = disabled (default)
	001 = 3.3 V
	010 = 3.35 V
	011 = 3.4 V
	100 = 3.45 V
	101 = 3.5 V
	110 = 3.55 V
	111 = 3.6 V

Set V\_VB\_LO = 000 to disable the low battery current foldback.

## PROGRAMMABLE BATTERY DC CURRENT LIMIT

The ADP1650 has four optional programmable input dc current limits that limit the maximum battery current that can be taken over all conditions. This allows higher LED currents to be used in a system with significant variation in LED forward voltage ( $V_F$ ) and supply battery voltage without risk of the current allocated to the flash being exceeded.

Table 7. Input DC Current Limit Setting the LED Current

Bit Name	Current Limit
IL_DC	00 = 1.5 A
	01 = 1.75 A
	10 = 2.0 A (default)
	11 = 2.25 A

During startup of the flash, if the battery current does not hit the dc current limit, the LED current is set to the current value of the I\_FL bits. If the battery current does hit the programmed dc current limit on startup, the LED current does not increase further. The dc current limit flag is set in the fault information register. The I\_FL bits in Register 0x03 are set to the actual LED current and are available for readback.

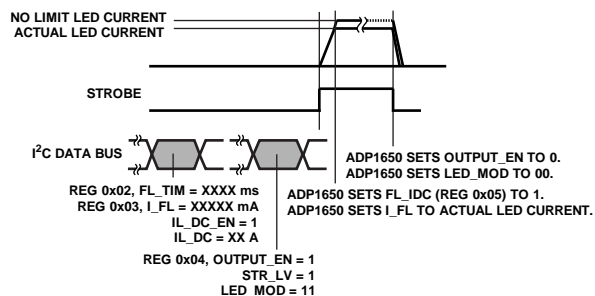


Figure 33. DC Current Limit Operation in a Low Battery, High LED  $V_F$  Case

The camera system shown in Figure 34 can adjust the image sensor settings based on the known reduced LED current for a low battery and a high  $V_F$  LED.

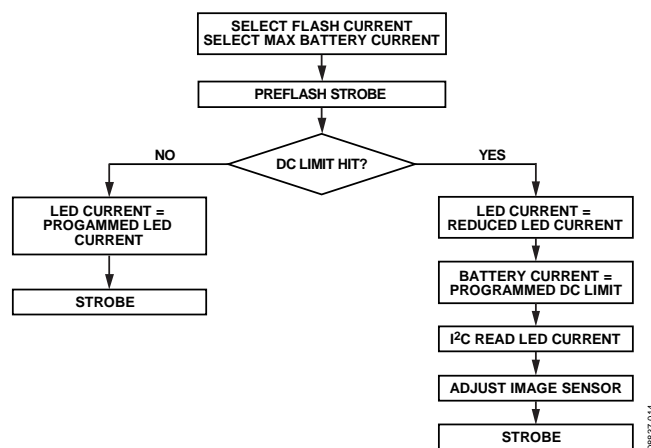


Figure 34. Use of the DC Current Limit in an Optimized Camera System

## ANALOG-TO-DIGITAL CONVERTER OPERATION

The internal 4-bit analog-to-digital converter (ADC) is configurable to measure the LED  $V_F$ , integrated circuit (IC) die temperature, or an external voltage using the GPIO2 pin. Read the 4-bit resolution output code back from Register 0x08 using the I<sup>2</sup>C interface.

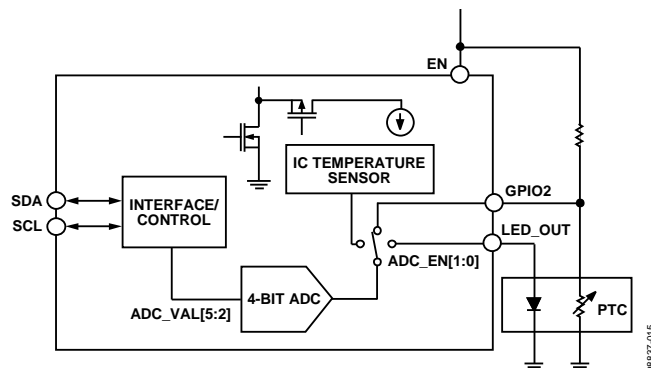


Figure 35. Available ADC Modes in the ADP1650

### LED $V_F$ Mode

The ADC can measure the LED  $V_F$  in both flash and assist/torch modes. In torch mode, set  $ADC\_EN = 01$  to begin a conversion. The value can be read back from the  $ADC\_VAL[5:2]$  bits 1 ms after the conversion has started. Assist/torch mode, rather than flash mode, is best in the handset production test to verify the LED  $V_F$ .

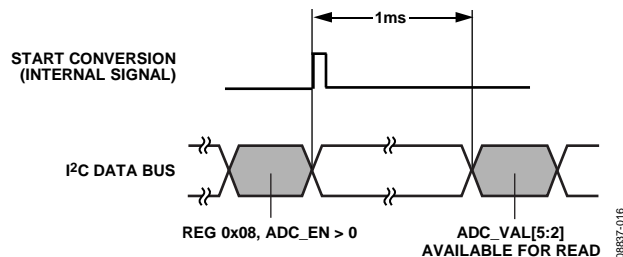


Figure 36. ADC Timing for All Modes Except  $V_F$  Measurement in Flash Mode

In flash mode, set  $ADC\_EN = 01$ . The conversion happens just before the timeout occurs; therefore, the  $FL\_TIM$  bits set when the ADC sample occurs. This allows the  $V_F$  to settle from the initial peak as the junction temperature of the LED stabilizes. An LED temperature vs. flash time profile for the handset PCB design can be generated during the design phase by varying the  $FL\_TIM$  bits from the lowest to the highest setting and collecting a  $V_F$  sample on each flash.

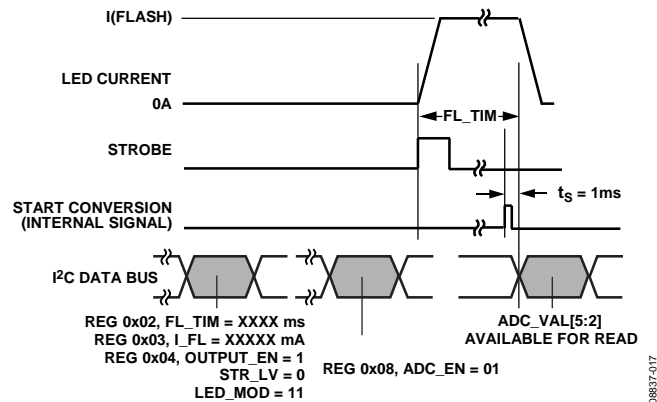


Figure 37. ADC Timing for  $V_F$  Measurement in Flash Mode

### Die Temperature Mode

The ADC measures the IC die temperature and provides the result to the I<sup>2</sup>C interface. This is useful during the design phase of the flash system to optimize PCB layout for the best thermal design.

Write  $ADC\_EN = 10$  to begin a die temperature measurement. The value can be read back from the  $ADC\_VAL[5:2]$  bits 1 ms after the conversion has started. The most stable and accurate value of die temperature is available at the end of the flash pulse.

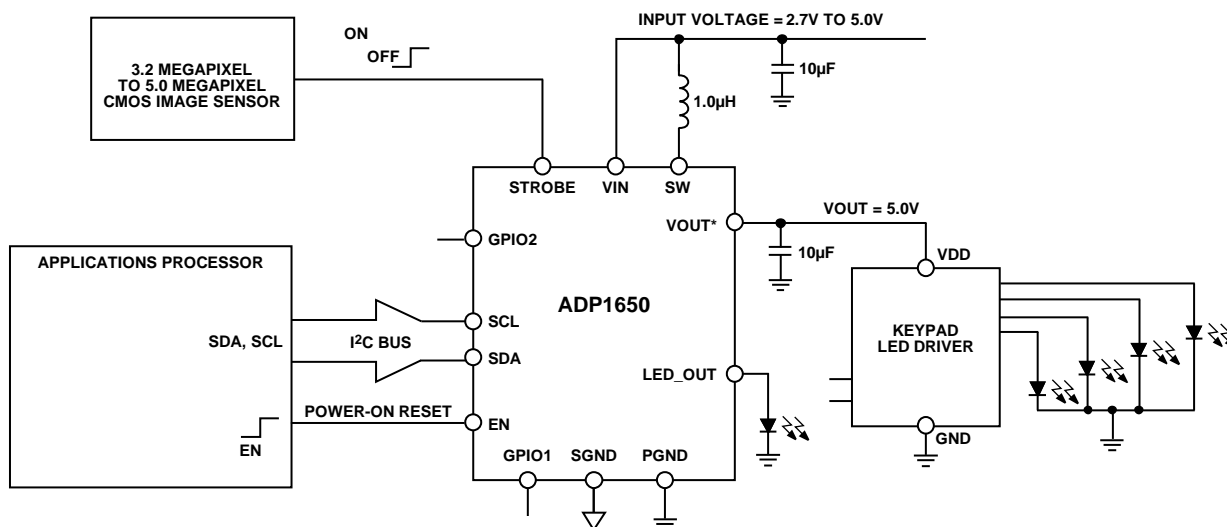
### External Voltage Mode

The ADC measures the voltage on the GPIO2 pin when the GPIO2 is configured as an ADC input by setting  $IO2\_CFG = 11$ . One example is using an external temperature-dependent resistor to create a voltage based on the temperature of the flash LED. The EN line can be used for biasing to reduce leakage current when the flash is not being used.



## 5 V OUTPUT OPERATION

The ADP1650 can be used as a 5 V boost to supply up to 500 mA for an audio voltage rail or keypad LED driver voltage. To move into voltage regulation mode, the OUTPUT\_EN bit must be set to 0. To enable the 5 V output, set LED\_MOD[1:0] = 01, and set OUTPUT\_EN = 1. The ADP1650 sets the VOUT pin to 5 V and disconnects VOUT from LED\_OUT. The VOUT pin is connected to the SW node when the ADP1650 is not enabled. VOUT should not be connected directly to a positive external voltage source because this will cause current to flow from VOUT to the battery.



\*THE VOUT PIN IS CONNECTED TO THE SW NODE WHEN THE ADP1650 IS NOT ENABLED. VOUT SHOULD NOT BE CONNECTED DIRECTLY TO A POSITIVE EXTERNAL VOLTAGE SOURCE BECAUSE THIS WILL CAUSE CURRENT TO FLOW FROM VOUT TO THE BATTERY.

Figure 38. ADP1650 Voltage Regulation Mode: LED Driver Application

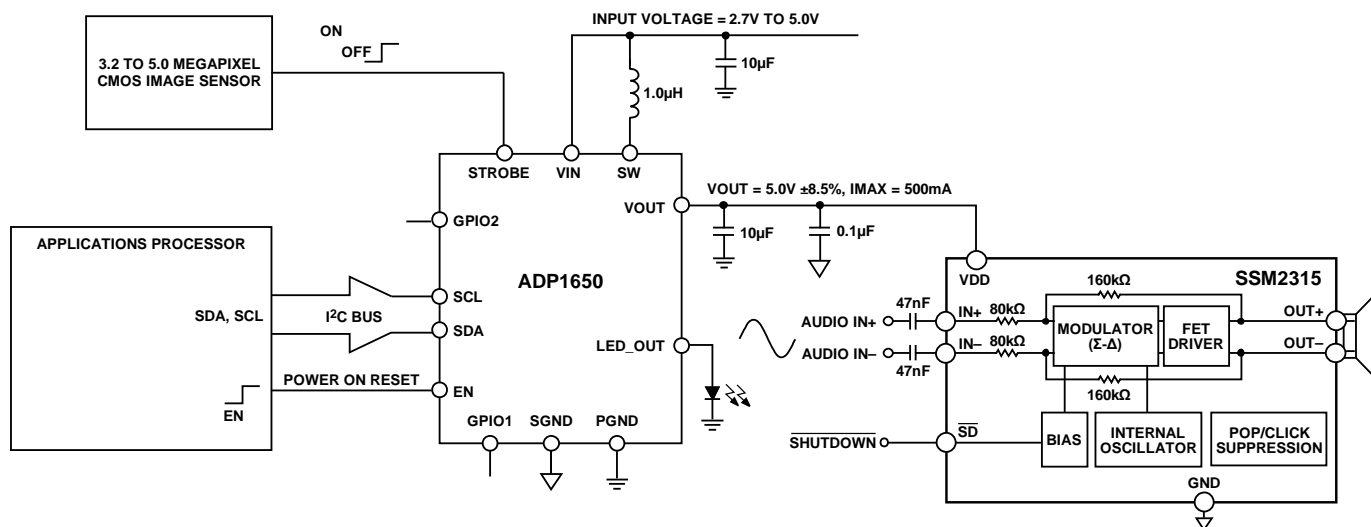


Figure 39. ADP1650 Voltage Regulation Mode: Class D Audio Application

## SAFETY FEATURES

For critical fault conditions, such as output overvoltage, flash timeout, LED output short circuit, and overtemperature conditions, the ADP1650 has built-in protection modes. If a critical fault occurs, OUTPUT\_EN (Register 0x04) is set to 0, and the driver shuts down. The appropriate fault bit is set in the fault information register (Register 0x05). The processor can read the fault information register through the I<sup>2</sup>C interface to determine the nature of the fault condition. When the fault register is read, the fault bit is cleared.

If a noncritical event such as an indicator LED open/short or a TxMASK1 or TxMASK2 event occurs or the dc current limit or soft inductor current limit is hit, the LED driver continues operating. The corresponding information bits are set in the fault information register until the processor reads them.

### SHORT-CIRCUIT FAULT

When the flash driver is disabled, the high side current regulator disconnects the dc path between the battery and the LED, protecting the system from an LED short circuit. The LED\_OUT pin features short-circuit protection that monitors the LED voltage when the LED driver is enabled. If the LED\_OUT pin remains below the short-circuit detection threshold, a short circuit is detected. Bit 6 of the fault information register is set high. The ADP1650 remains disabled until the processor clears the fault register.

### OVERVOLTAGE FAULT

The ADP1650 contains a comparator at the VOUT pin that monitors the voltage between VOUT and GND. If the voltage exceeds 5.5 V (typical), the ADP1650 shuts down. Bit 7 in the fault information register is read back as high. The ADP1650 is disabled until the fault is cleared, ensuring protection against an open circuit.

### DYNAMIC OVERVOLTAGE MODE (DOVP)

Dynamic OVP mode is a programmable feature that limits the VOUT voltage exceeding the OVP level while maintaining as much current as possible through the LED. This mode prevents an overvoltage fault in the case of a much higher than expected LED forward voltage. If the LED forward voltage reduces due to the LED temperature rising, the ADP1650 moves out of DOVP mode and regulates the LED at the programmed current level. Set Bit 7 of Register 0x07 high to enable dynamic OVP mode.

### TIMEOUT FAULT

When external strobe mode is enabled (Register 0x04, Bit 2), and strobe is set to level-sensitive mode (Register 0x04, Bit 5), if the strobe pin remains high for longer than the programmed timeout period, the timeout fault bit (Register 0x05, Bit 4) is read back as high. The ADP1650 remains disabled until the processor clears the fault register.

### OVERTEMPERATURE FAULT

If the junction temperature of the ADP1650 rises above 150°C, a thermal protection circuit shuts down the device. Bit 5 of the fault information register is set high. The ADP1650 remains disabled until the processor clears the fault register.

### INDICATOR LED FAULT

The GPIO2 pin features open- and short-circuit protection in the indicator LED mode. If a short or open circuit occurs, Bit 2 of the fault information register is set high. The indicator LED regulator ensures that no damage occurs to the IC during a fault.

### CURRENT LIMIT

The internal switch limits battery current by ensuring that the peak inductor current does not exceed the programmed limit (current limit is set by Bit 6 and Bit 7 in Register 0x04). The default mode of the ADP1650 is soft current limit mode. If the peak inductor current hits the limit, Bit 1 of the fault information register is set, and the inductor and LED current cannot increase further. The ADP1650 continues to operate. If the ADP1650 has soft current limit disabled and the peak inductor current exceeds the limit, the part shuts down and Bit 1 of the fault information register is set high. In this case, ADP1650 remains disabled until the processor clears the fault register.

### INPUT UNDERVOLTAGE

The ADP1650 includes a battery undervoltage lockout circuit. During 5 V or LED operation, if the battery voltage drops below the 2.4 V (typical) input UVLO threshold, the ADP1650 shuts down. A power-on reset circuit resets the registers to their default conditions when the voltage rises above the UVLO rising threshold.

### SOFT START

The ADP1650 has a soft start mode that controls the rate of increase of battery current at startup by digitally controlling the output current ramp. The maximum soft start time is 0.6 ms.

### RESET USING THE ENABLE (EN) PIN

A low-to-high transition on the EN pin resets all registers to their default values. Bringing EN low reduces the I<sub>q</sub> to 0.2 μA (typical).

### CLEARING FAULTS

Information bits and faults in Register 0x05 clear automatically when the processor reads the fault register.

## I<sup>2</sup>C INTERFACE

The ADP1650 includes an I<sup>2</sup>C-compatible serial interface for control of the LED current, as well as for readback of system status registers. The I<sup>2</sup>C chip address is 0x30 (0x60 in write mode and 0x61 in read mode). Additional I<sup>2</sup>C addresses are available on request.

Figure 41 illustrates the I<sup>2</sup>C write sequence to a single register. The subaddress content selects which of the nine ADP1650 registers is written to. The ADP1650 sends an acknowledgment to the master after the 8-bit data byte has been written. Figure 42 shows the I<sup>2</sup>C read sequence of a single register.

The register definitions are shown in the I<sup>2</sup>C Register Map section.

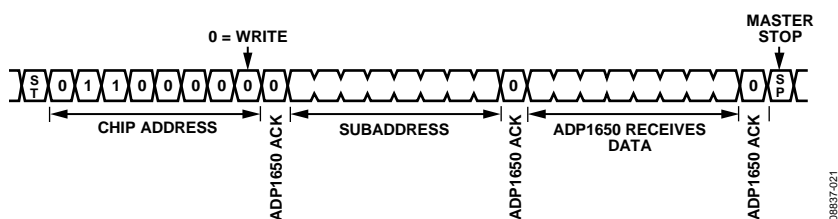


Figure 40. I<sup>2</sup>C Single Register Write Sequence

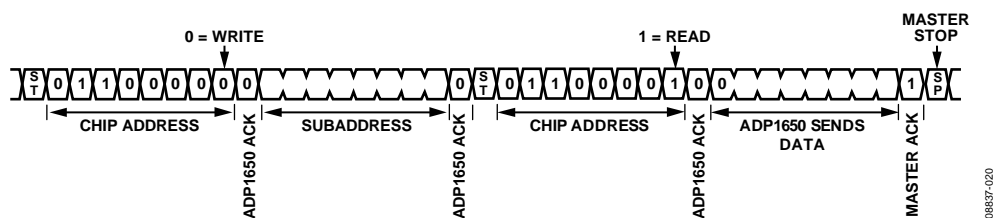


Figure 41. I<sup>2</sup>C Single Register Read Sequence

## I<sup>2</sup>C REGISTER MAP

The lowest bit number (0) represents the least significant bit, and the highest bit number (7) represents the most significant bit.

**Table 8. Design Information Register (Register 0x00)**

Bit	R/W	Reset State
7:0	R	00100010

**Table 9. VREF and Timer Register (Register 0x02)**

Bit Name	Bit	R/W	Description
IO2_CFG	7:6	R/W	GPIO2 configuration 00 = high impedance (default) 01 = indicator LED 10 = TxMASK2 operation mode 11 = analog input (to ADC)
IO1_CFG	5:4	R/W	GPIO1 configuration 00 = high impedance (default) 01 = torch 10 = TxMASK1 operation mode 11 = reserved
FL_TIM	3:0	R/W	Flash timer value setting 0000 = 100 ms 0001 = 200 ms 0010 = 300 ms 0011 = 400 ms 0100 = 500 ms 0101 = 600 ms 0110 = 700 ms 0111 = 800 ms 1000 = 900 ms 1001 = 1000 ms 1010 = 1100 ms 1011 = 1200 ms 1100 = 1300 ms 1101 = 1400 ms 1110 = 1500 ms 1111 = 1600 ms (default)

Table 10. Current Set Register (Register 0x03)

Bit Name	Bit	R/W	Description
I_FL	7:3	R/W	Flash current value setting 00000 = 300 mA 00001 = 350 mA 00010 = 400 mA 00011 = 450 mA 00100 = 500 mA 00101 = 550 mA 00110 = 600 mA 00111 = 650 mA 01000 = 700 mA 01001 = 750 mA 01010 = 800 mA 01011 = 850 mA 01100 = 900 mA 01101 = 950 mA 01110 = 1000 mA (default) 01111 = 1050 mA 10000 = 1100 mA 10001 = 1150 mA 10010 = 1200 mA 10011 = 1250 mA 10100 = 1300 mA 10101 = 1350 mA 10110 = 1400 mA 10111 = 1450 mA 11000 = 1500 mA
I_TOR	2:0	R/W	Torch and assist light current value setting 000 = 25 mA 001 = 50 mA 010 = 75 mA 011 = 100 mA (default) 100 = 125 mA 101 = 150 mA 110 = 175 mA 111 = 200 mA

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**Table 11. Output Mode Register (Register 0x04)**

Bit Name	Bit	R/W	Description
IL_PEAK	7:6	R/W	Inductor peak current limit setting 00 = 1.75 A 01 = 2.25 A 10 = 2.75 A (default) 11 = 3.0 A
STR_LV	5	R/W	0 = edge sensitive 1 = level sensitive (default)
FREQ_FB	4	R/W	0 = frequency foldback to 1.5 MHz not allowed (default) 1 = frequency foldback to 1.5 MHz allowed
OUTPUT_EN	3	R/W	0 = output off (default) 1 = output on
STR_MODE	2	R/W	0 = software strobe mode (software flash occurs when output is enabled in flash mode) 1 = hardware strobe mode (the STROBE pin must go high for flash) (default)
LED_MOD	1:0	R/W	Configures LED output mode 00 = standby mode (default) 01 = voltage output mode, VOUT = 5 V 10 = assist light mode 11 = flash mode

**Table 12. Fault Information Register (Fault, Register 0x05)**

Bit Name	Bit	R/W	Description
FL_OVP	7	R	0 = no fault (default) 1 = overvoltage fault
FL_SC	6	R	0 = no fault (default) 1 = short-circuit fault
FL_OT	5	R	0 = no fault (default) 1 = overtemperature fault
FL_TO	4	R	0 = no fault (default) 1 = timeout fault
FL_TX1	3	R	0 = no TxMASK1 operation mode during last flash (default) 1 = TxMASK1 operational mode occurred during last flash
FL_IO2	2	R	If GPIO2 is configured as TxMASK2 0 = no TxMASK2 operations mode during last flash (default) 1 = TxMASK2 operational mode occurred during last flash If GPIO2 is configured as ILED 0 = no fault (default) 1 = indicator LED Fault
FL_IL	1	R	0 = no fault (default) 1 = inductor peak current limit fault
FL_IDC	0	R	0 = programmed dc current limit not hit (default) 1 = programmed dc current limit hit

Table 13. Input Control Register (Register 0x06)

Bit Name	Bit	R/W	Description
I_TX2	7:4	R/W	TxMASK2 operational mode foldback current 0000 = 100 mA 0001 = 150 mA 0010 = 200 mA 0011 = 250 mA 0100 = 300 mA 0101 = 350 mA 0110 = 400 mA (default) 0111 = 450 mA 1000 = 500 mA 1001 = 550 mA 1010 = 600 mA 1011 = 650 mA 1100 = 700 mA 1101 = 750 mA 1110 = 800 mA 1111 = 850 mA
I_TX1	3:0	R/W	TxMASK1 operational mode foldback current 0000 = 100 mA 0001 = 150 mA 0010 = 200 mA 0011 = 250 mA 0100 = 300 mA 0101 = 350 mA 0110 = 400 mA (default) 0111 = 450 mA 1000 = 500 mA 1001 = 550 mA 1010 = 600 mA 1011 = 650 mA 1100 = 700 mA 1101 = 750 mA 1110 = 800 mA 1111 = 850 mA

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**Table 14. Additional Mode Register (AD\_MOD, Register 0x07)**

Bit Name	Bit	R/W	Description
DYN_OVP	7	R/W	Dynamic OVP 0 = dynamic OVP off (default) 1 = dynamic OVP on
SW_LO	6	R/W	Force 1.5 MHz switching frequency 0 = disabled (default) 1 = enabled
STR_POL	5	R/W	Strobe polarity 0 = active low 1 = active high (default)
I_ILED	4:3	R/W	Indicator LED current 00 = 2.75 mA (default) 01 = 5.5 mA 10 = 8.25 mA 11 = 11 mA
IL_DC	2:1	R/W	Input dc current limit setting LED current 00 = 1.5 A 01 = 1.75 A 10 = 2.0 A (default) 11 = 2.25 A
IL_DC_EN	0	R/W	Input dc current limit 0 = disabled (default) 1 = enabled

**Table 15. Additional Mode Register, ADC (Register 0x08)**

Bit Name	Bit	R/W	Description
Reserved	7	R/W	Test mode 0 = disabled (default) 1 = enabled
FL_VB_LO	6	R	Programmed VBAT low threshold status; low battery mode must be enabled in Register 0x09 0 = VDD is greater than the VBAT low threshold (default) 1 = VDD is less than the VBAT low threshold
ADC_VAL	5:2	R/W	ADC readback value; four bits. See Figure 16, Figure 17, and Figure 18
ADC_EN	1:0	R/W	ADC enable mode 00 = disabled (default) 01 = LED $V_F$ measurement 10 = die temperature measurement 11 = external voltage mode



Table 16. Battery Low Mode Register (Register 0x09)

Bit Name	Bit	R/W	Description
CL_SOFT	7	R/W	Soft inductor peak current limit 0 = disabled (ADP1650 is disabled when the inductor peak current limit is hit) 1 = enabled (default)
I_VB_LO	6:3	R	Current setting for VBAT low mode 0000 = 300 mA 0001 = 350 mA 0010 = 400 mA 0011 = 450 mA 0100 = 500 mA 0101 = 550 mA 0110 = 600 mA 0111 = 650 mA 1000 = 700 mA 1001 = 750 mA 1010 = 800 mA (default) 1011 = 850 mA 1100 = 900 mA 1101 = 950 mA 1110 = 1000 mA 1111 = 1050 mA
V_VB_LO	2:0	R/W	VDD level where VBAT low function is enabled 000 = disabled (default) 001 = 3.3 V 010 = 3.35 V 011 = 3.4 V 100 = 3.45 V 101 = 3.5 V 110 = 3.55 V 111 = 3.6 V

## APPLICATIONS INFORMATION

### EXTERNAL COMPONENT SELECTION

#### Selecting the Inductor

The ADP1650 boost converter increases the battery voltage to allow driving of one LED, whose voltage drop is higher than the battery voltage plus the current source headroom voltage. This allows the converter to regulate the LED current over the entire battery voltage range and with a wide variation of LED forward voltage.

The inductor saturation current should be greater than the sum of the dc input current and half the inductor ripple current. A reduction in the effective inductance due to saturation increases the inductor current ripple. Table 18 provides a list of recommended inductors.

**Table 17. Suggested Inductors**

Vendor	Value (μH)	Part No.	DCR (mΩ)	ISAT (A)	Dimensions L × W × H (mm)
Toko	1.0	FDSD0312	41.5	4.5	3.0 × 3.0 × 1.2
Toko	1.0	DFE2520	50	3.4	2.5 × 2.0 × 1.2
Coilcraft	1.0	XFL3010	43	2.4	3.0 × 3.0 × 1.0
Murata	1.0	LQM32P_G0	60	3	3.2 × 2.5 × 1.0
FDK	1.0	MIPS3226D	40	3	2.5 × 2.0 × 1.2

#### Selecting the Input Capacitor

The ADP1650 requires an input bypass capacitor to supply transient currents while maintaining constant input and output voltages. The input capacitor carries the input ripple current, allowing the input power source to supply only the dc current. Increased input capacitance reduces the amplitude of the switching frequency ripple on the battery. Due to the dc bias characteristics of ceramic capacitors, a 0603, 6.3 V, X5R/X7R, 10 μF ceramic capacitor is preferable.

Higher value input capacitors help to reduce the input voltage ripple and improve transient response.

To minimize supply noise, place the input capacitor as close to the VIN pin of the ADP1650 as possible. As with the output capacitor, a low ESR capacitor is required. Table 19 provides a list of suggested input capacitors.

**Table 18. Suggested Input Capacitors**

Vendor	Value	Part No.	Dimensions L × W × H (mm)
Murata	10 μF, 6.3 V	GRM188R60J106ME47	1.6 × 0.8 × 0.8
TDK	10 μF, 6.3 V	C1608JB0J106K	1.6 × 0.8 × 0.8
Taiyo Yuden	10 μF, 6.3 V	JMK107BJ106MA	1.6 × 0.8 × 0.8

#### Selecting the Output Capacitor

The output capacitor maintains the output voltage and supplies the LED current during the NFET power switch on period. It also stabilizes the loop. The recommended capacitor is a 10.0 μF, 6.3 V, X5R/X7R ceramic capacitor.

Note that dc bias characterization data is available from capacitor manufacturers and should be taken into account when selecting input and output capacitors. The 6.3 V capacitors are best for most designs. Table 20 provides a list of recommended output capacitors.

**Table 19. Suggested Output Capacitors**

Vendor	Value	Part No.	Dimensions L × W × H (mm)
Murata	10 μF, 6.3 V	GRM188R60J106ME47	1.6 × 0.8 × 0.8
TDK	10 μF, 6.3 V	C1608JB0J106K	1.6 × 0.8 × 0.8
Taiyo Yuden	10 μF, 6.3 V	JMK107BJ106MA	1.6 × 0.8 × 0.8

Higher output capacitor values reduce the output voltage ripple and improve load transient response. When choosing this value, it is also important to account for the loss of capacitance due to output voltage dc bias.

Ceramic capacitors have a variety of dielectrics, each with different behavior over temperature and applied voltage. Capacitors must have a dielectric that ensures the minimum capacitance over the necessary temperature range and dc bias conditions. X5R or X7R dielectrics with a voltage rating of 6.3 V or 10 V are recommended for best performance. Y5V and Z5U dielectrics are not recommended for use with any dc-to-dc converter because of their poor temperature and dc bias characteristics.

The worst-case capacitance accounting for capacitor variation over temperature, component tolerance, and voltage is calculated using the following equation:

$$C_{EFF} = C_{OUT} \times (1 - TEMPCO) \times (1 - TOL)$$

where:

$C_{EFF}$  is the effective capacitance at the operating voltage.

$TEMPCO$  is the worst-case capacitor temperature coefficient.

$TOL$  is the worst-case component tolerance.

In this example, the 10 $\mu$ F X5R capacitor has the following:

$TEMPCO$  from  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$  is 15%.

$TOL$  is 10%.

$C_{OUT}$  at  $V_{OUT}(\text{MAX}) = 5\text{ V}$ , is 7  $\mu\text{F}$ , as shown in Figure 43.

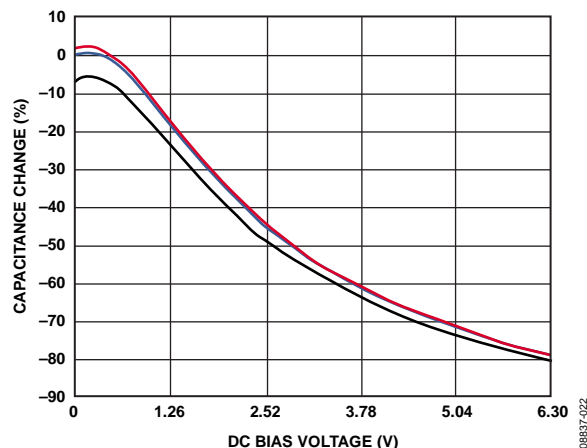


Figure 42. DC Bias Characteristic of a 3 x 6.3 V, 10  $\mu\text{F}$  Ceramic Capacitor

Substituting these values in the equation yields

$$C_{EFF} = 7\text{ }\mu\text{F} \times (1 - 0.15) \times (1 - 0.1) = 5.35\text{ }\mu\text{F}$$

The effective capacitance needed for stability, which includes temperature and dc bias effects, is 3.0  $\mu\text{F}$ .

## PCB LAYOUT

Poor layout can affect performance, causing electromagnetic interference (EMI) and electromagnetic compatibility (EMC) problems, ground bounce, and power losses. Poor layout can also affect regulation and stability. Figure 44 shows optimized layouts implemented using the following guidelines:

- Place the inductor, input capacitor, and output capacitor close to the IC using short tracks. These components carry high switching frequencies and large currents.
- Route the trace from the inductor to the SW pin with as wide a trace as possible. The easiest path is through the center of the output capacitor.
- Route the LED\_OUT path away from the inductor and SW node to minimize noise and magnetic interference.
- Maximize the size of ground metal on the component side to help with thermal dissipation.
- Use a ground plane with two to three vias connecting to the component side ground near the output capacitor to reduce noise interference on sensitive circuit nodes.
- Analog Devices applications engineers can be contacted through the Analog Devices sales team to discuss different layouts based on system design constraints.

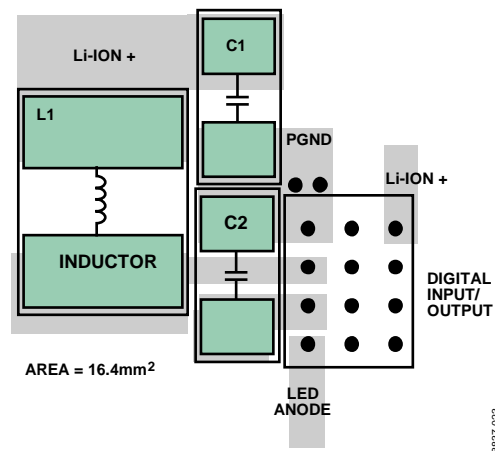


Figure 43. Layout of the ADP1650 Driving a High Power White LED

# OUTLINE DIMENSIONS

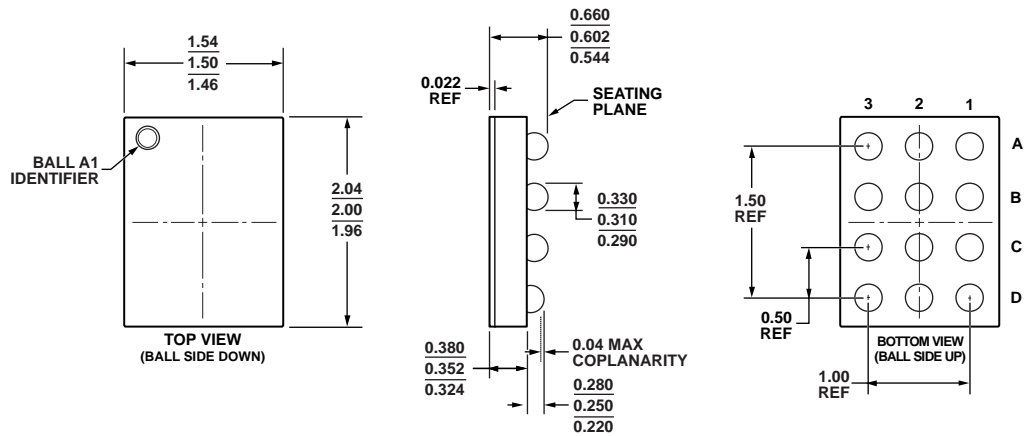


Figure 36. 12-Ball Wafer Level Chip Scale Package [WLCSP]  
(CB-12-4)  
Dimensions shown in millimeters

020409-B

## ORDERING GUIDE

Model <sup>1</sup>	Temperature Range	Package Description	Package Option	Branding
ADP1650ACBZ-R7	−40°C to +125°C	12-Ball Wafer Level Chip Scale Package [WLCSP]	CB-12-4 <sup>2</sup>	LE4
ADP1650CB-EVALZ		Evaluation Board		

<sup>1</sup> Z= RoHS Compliant Part.  
<sup>2</sup> This package option is halide free.

**ADP1650**

**NOTES**

**NOTES**

## NOTES

I<sup>2</sup>C refers to a communications protocol originally developed by Philips Semiconductors (now NXP Semiconductors).